

Search Notes

Application/Control No.

10/824,959

Examiner

Anh D. Mai

Applicant(s)/Patent under
Reexamination

XIAO ET AL.

Art Unit

2814

SEARCHED

Class	Subclass	Date	Examiner
365	157; 158 171; 173	7/19/2005	A.M
257	295	7/19/2005	A.M

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (all) * Inventors * CCLS * MTJ and buffer and seed and antiferromagnetic and pin\$5 and barrier and free * MTJ and PtMn and IrMn	7/19/05	A.M
NPL: Applied Physics Letter	7/19/2005	A.M